



### DESCRIPTION

The ES3AC\_ES3JC are available in SMC Package

- For surface mounted applications
- Low profile package
- Glass Passivated Chip Junction
- Superfast reverse recovery time

### MECHANICAL DATA

- Case: SMC
- Terminals: Solderable per MIL-STD-750, Method 2026
- Approx. Weight: 0.22g / 0.0077oz

### ORDERING INFORMATION

Package Type	Part Number
SMC	ES3AC
	ES3BC
	ES3CC
	ES3DC
	ES3EC
	ES3GC
	ES3JC
SPQ	3,000pcs/Reel
AiT provides all RoHS Compliant Products	

### PIN DESCRIPTION



PIN #	DESCRIPTION
1	Cathode
2	Anode



**ABSOLUTE MAXIMUM RATINGS AND ELECTRICAL CHARACTERISTICS**

@ T<sub>A</sub> = 25°C, unless otherwise specified. Single phase, half wave, 60 Hz, resistive or inductive load.  
For capacitive load, derate current by 20%.

Parameter	Symbol	ES3AC	ES3BC	ES3CC	ES3DC	Units
Maximum Repetitive Peak Reverse Voltage	V <sub>RRM</sub>	50	100	150	200	V
Maximum RMS voltage	V <sub>RMS</sub>	35	70	105	140	V
Maximum DC Blocking Voltage	V <sub>DC</sub>	50	100	150	200	V
Maximum Average Forward Rectified Current at T <sub>A</sub> = 125 °C	I <sub>F(AV)</sub>	3				A
Peak Forward Surge Current 8.3 ms Single Half Sine Wave Superimposed on Rated Load	I <sub>FSM</sub>	90				A
Maximum Forward Voltage at 3 A	V <sub>F</sub>	1				V
Maximum DC Reverse Current T <sub>A</sub> = 25°C at Rated DC Blocking Voltage T <sub>A</sub> =125°C	I <sub>R</sub>	5 100				μA
Typical Junction Capacitance at V <sub>R</sub> =4V, f=1MHz	C <sub>j</sub>	40				pF
Maximum Reverse Recovery Time <sup>(1)</sup>	t <sub>rr</sub>	35				ns
Typical Thermal Resistance <sup>(2)</sup>	R <sub>θJA</sub>	40				°C/W
	R <sub>θJC</sub>	16				
Junction Temperature	T <sub>J</sub>	+150				°C
Storage Temperature Range	T <sub>stg</sub>	-55~+150				°C

(1) Measured with I<sub>F</sub> = 0.5 A, I<sub>R</sub> = 1 A, I<sub>rr</sub> = 0.25 A.

(2) P.C.B. mounted with 1.0 X 1.0" (2.54 X 2.54 cm) copper pad areas.

Stresses above may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated in the Electrical Characteristics are not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



Parameter	Symbol	ES3EC	ES3GC	ES3JC	Units
Maximum Repetitive Peak Reverse Voltage	$V_{RRM}$	300	400	600	V
Maximum RMS voltage	$V_{RMS}$	210	280	420	V
Maximum DC Blocking Voltage	$V_{DC}$	300	400	600	V
Maximum Average Forward Rectified Current at $T_A = 125^\circ\text{C}$	$I_{F(AV)}$	3			A
Peak Forward Surge Current 8.3 ms Single Half Sine Wave Superimposed on Rated Load	$I_{FSM}$	90			A
Maximum Forward Voltage at 3 A	$V_F$	1.25		1.68	V
Maximum DC Reverse Current at Rated DC Blocking Voltage	$I_R$	5 100			$\mu\text{A}$
Typical Junction Capacitance at $V_R=4\text{V}$ , $f=1\text{MHz}$	$C_j$	40			pF
Maximum Reverse Recovery Time <sup>(1)</sup>	$t_{rr}$	35			ns
Typical Thermal Resistance <sup>(2)</sup>	$R_{\theta JA}$	40			$^\circ\text{C/W}$
	$R_{\theta JC}$	16			
Junction Temperature	$T_J$	+150			$^\circ\text{C}$
Storage Temperature Range	$T_{stg}$	-55~+150			$^\circ\text{C}$

(1) Measured with  $I_F = 0.5\text{ A}$ ,  $I_R = 1\text{ A}$ ,  $I_{rr} = 0.25\text{ A}$ .

(2) P.C.B. mounted with 1.0 X 1.0" (2.54 X 2.54 cm) copper pad areas.

Stresses above may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated in the Electrical Characteristics are not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



## TYPICAL CHARACTERISTICS

Fig 1. Maximum Average Forward Current Rating

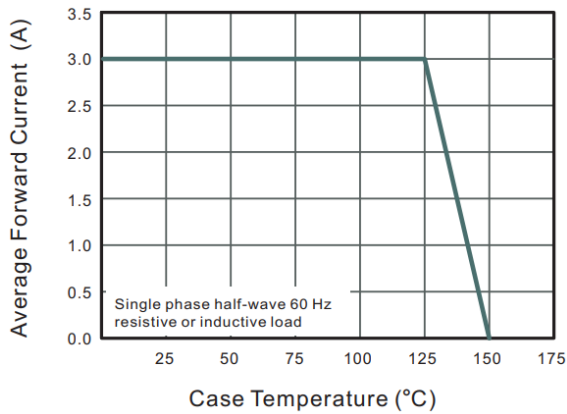


Fig 2. Typical Reverse Characteristics

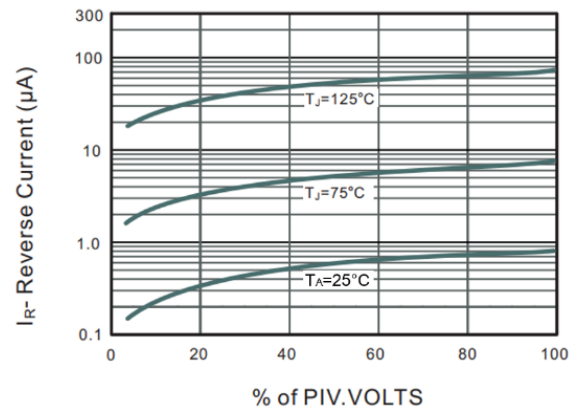


Fig 3. Typical Forward Characteristics

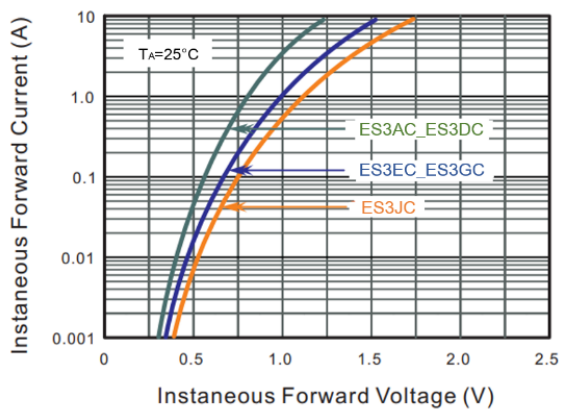


Fig 4. Typical Junction Capacitance

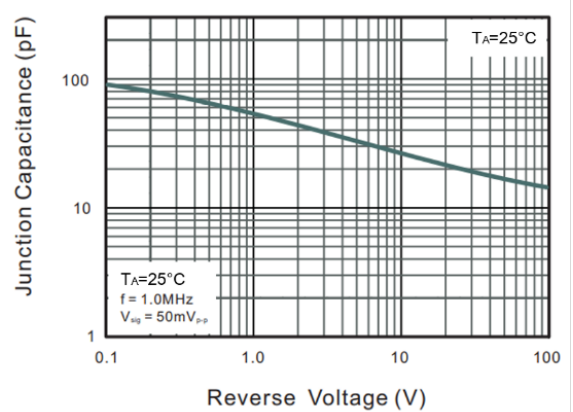


Fig 5. Maximum Non-Repetitive vs. Peak Forward Surge Current

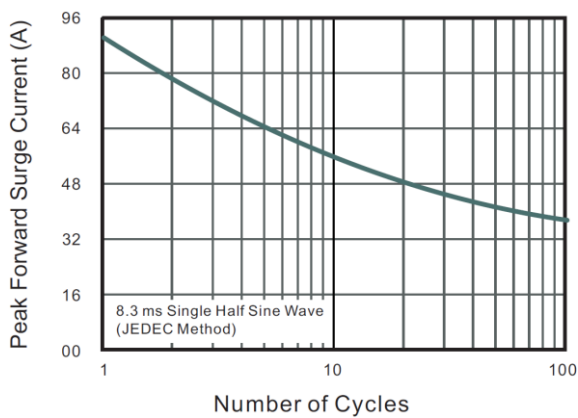
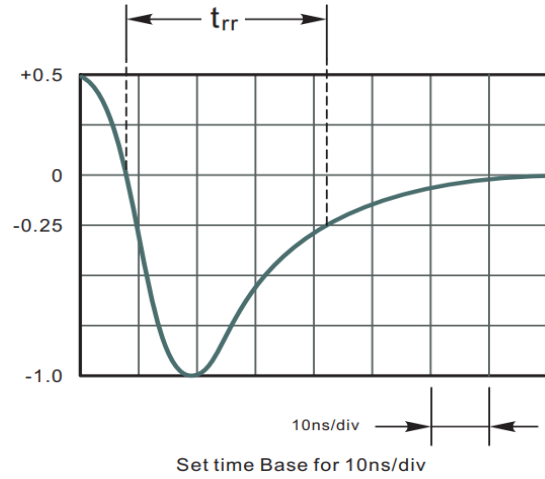
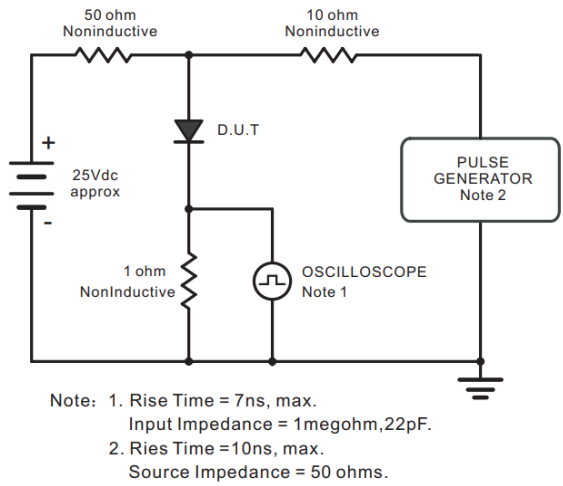




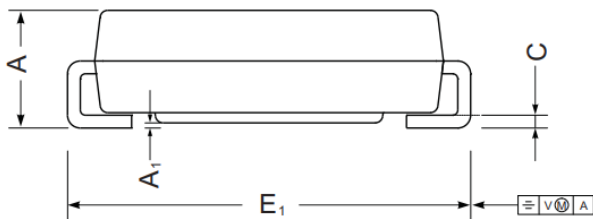
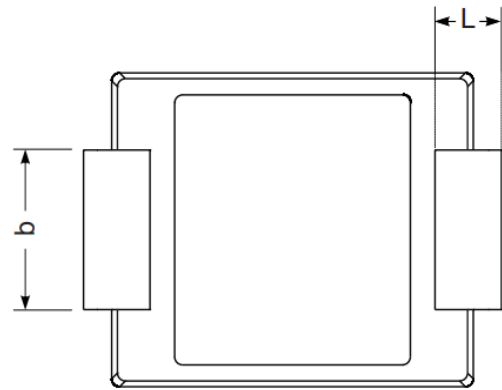
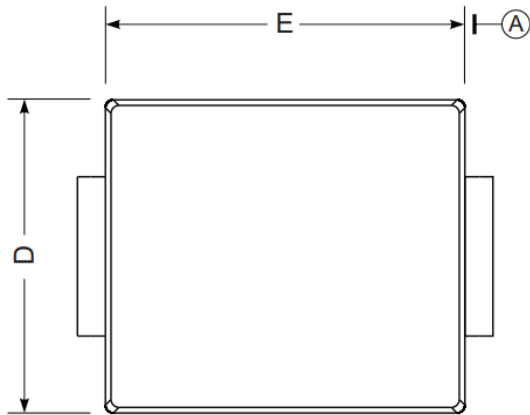
Fig.6 Reverse Recovery Time Characteristic and Test Circuit Diagram





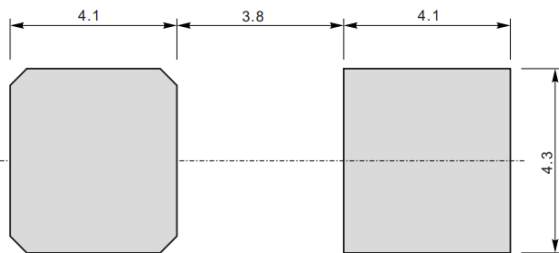
**PACKAGE INFORMATION**

Dimension in SMC (Unit: mm)



Symbol	Min.	Max.
A	2.000	2.620
E	6.500	7.000
D	5.600	6.200
E <sub>1</sub>	7.600	8.000
A <sub>1</sub>	0.050	0.210
C	0.150	0.310
L	0.900	1.600
b	2.750	3.250

The recommended mounting pad size



Unit : mm



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